Shenzhen Huatongwei International Inspection Co., Ltd.

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FCC REPORT

Report Reference No.....: CHTEW20120100 Report verification:

Project No.:: SHT2011064601EW

FCC ID.....:: **2AAA6-LS140L**

Applicant's name: SENWA MEXICO, S.A.DE C.V

CARRETERA MEXICO-TOLUCA No. 5324, INT. PLANTA BAJA Address.....:

COL. EL YAQUI, CUAJIMALPA DE MORELOS CIUDAD DE

MEXICO, Mexico

Manufacturer....: SENWA GLOBAL INTERNATIONAL SA DE CV

Address....: Rm.1218 Block A Chuangxin Building No.198 Daxin RD.Nanshan

District ShenZhen

Test item description:: Mobile phone

Trade Mark: **SENWA**

Model/Type reference..... LS140L

Listed Model(s)

FCC CFR Title 47 Part 2 Standard::

> FCC CFR Title 47 Part 22 FCC CFR Title 47 Part 24 FCC CFR Title 47 Part 27

Date of receipt of test sample..... Nov. 30, 2020

Date of testing..... Dec. 01, 2020- Dec. 15, 2020

Date of issue....: Dec. 16, 2020

Result....: **Pass**

Testing Laboratory Name::

Compiled by

(position+printedname+signature)...: File administrators Silvia Li

Supervised by

(position+printedname+signature)....: Project Engineer Aaron Fang Silvia Li

Aaron.Fang

Homsty

Approved by

(position+printedname+signature)....: Manager Hans Hu

Shenzhen Huatongwei International Inspection Co., Ltd.

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The test report merely correspond to the test sample.

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1. TEST STANDARDS AND REPORT VERSION

1.1. Applicable Standards

The tests were performed according to following standards:

FCC Rules Part 2: FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS

FCC Rules Part 22: PUBLIC MOBILE SERVICES

FCC Rules Part 24: PERSONAL COMMUNICATIONS SERVICES

FCC Rules Part 27: MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

ANSI C63.26: 2015: American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

KDB 971168 D01 Power Meas License Digital Systems v03: MEASUREMENT GUIDANCE FOR

CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS

1.2. Report version information

Revision No.	Date of issue	Description
N/A	2020-12-16	Original

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2. Test Description

Test Item	Section in CFR 47	Result	Test Engineer	
	Part 2.1046			
Conducted Output Power	Part 22.913(a)	Pass	Jiongsheng Feng	
Conducted Output Fower	Part 24.232(c)	F 435	Jiongsheng reng	
	Part 27.50			
Dook to Average Detic	Part 24.232	Door	lian sahana Fana	
Peak-to-Average Ratio	Part 27.50	Pass	Jiongsheng Feng	
	Part 2.1049			
99% Occupied Bandwidth & 26 dB	Part 22.917(b)	Pass	liongohang Fang	
Bandwidth	Part 24.238(b)	Pass	Jiongsheng Feng	
	Part 27.53			
	Part 2.1051			
Dond Edge	Part 22.917	Pass	liongohong Fong	
Band Edge	Part 24.238	Pass	Jiongsheng Feng	
	Part 27.53			
	Part 2.1051			
Canducted Spurious Emissions	Part 22.917	Door	liongohang Fang	
Conducted Spurious Emissions	Part 24.238	Pass	Jiongsheng Feng	
	Part 27.53			
	Part 2.1055(a)(1)(b)		liongohong Fong	
Francisco et al ilita VC Tarana aratura	Part 22.355	Dana		
Frequency stability VS Temperature	Part 24.235	Pass	Jiongsheng Feng	
	Part 27.54			
	Part 2.1055(d)(1)(2)			
Fragues as a tability VS Valtage	Part 22.355	Pass	liongobers Tags	
Frequency stability VS Voltage	Part 24.235	Pass	Jiongsheng Feng	
	Part 27.54			
	Part 22.913(a)			
EIRP	Part 24.232(b)	Pass	Pan Xie	
	Part 27.50			
	Part 2.1053			
Padiated Spurious Emissions	Part 22.917	Pass	Pan Xie	
Radiated Spurious Emissions	Part 24.238	F 455	Fall Ale	
	Part 27.53			

Note: The measurement uncertainty is not included in the test result.

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3. **SUMMARY**

3.1. Client Information

Applicant:	SENWA MEXICO,S.A.DE C.V
Address:	CARRETERA MEXICO-TOLUCA No. 5324, INT. PLANTA BAJA COL. EL YAQUI, CUAJIMALPA DE MORELOS CIUDAD DE MEXICO, Mexico
Manufacturer:	SENWA GLOBAL INTERNATIONAL SA DE CV
Address:	Rm.1218 Block A Chuangxin Building No.198 Daxin RD.Nanshan District ShenZhen

3.2. Product Description

Name of EUT:	Mobile phone					
Trade Mark:	SENWA					
Model No.:	LS140L					
Listed Model(s):	-	-				
SIM Information:	Support One SIM Ca	Support One SIM Card				
Power supply:	DC 3.7V					
Adapter information:	'	Input: AC100-240V, 50/60Hz, 0.15A Output: 5.0Vdc,500mA				
Hardware version:	SENWA_LS140L_Ve	er1.0				
Software version:	SENWA_LS140L_Ve	er1.0				
4G						
Operation Band:	☑ FDD Band 2☑ FDD Band 66	⊠ FDD Band 4	⊠ FDD Band 7			
Transmit frequency:	FDD Band 2: FDD Band 4: FDD Band 7: FDD Band 66:	1850.7 MHz – 1909.3 1710.7 MHz – 1754.3 2502.5 MHz – 2567.5 1710.7 MHz – 1779.3	B MHz 5 MHz			
Receive frequency:	FDD Band 2: FDD Band 4: FDD Band 7: FDD Band 66:	1930.7 MHz – 1989.3 2110.7 MHz – 2154.3 2622.5 MHz – 2687.5 2110.7 MHz – 2179.3	3 MHz 5 MHz			
Channel bandwidth:	FDD Band 2: FDD Band 4: FDD Band 7: FDD Band 66:	1.4MHz, 3MHz, 5MH: 5MHz, 10MHz, 15MH	z, 10MHz, 15MHz, 20MHz z, 10MHz, 15MHz, 20MHz Hz, 20MHz z, 10MHz, 15MHz, 20MHz			
Power Class:	Class 3					
Modulation type:	QPSK, 16QAM					
Antenna type	PIFA Antenna					
Antenna Gain	Band2:0.7dBi Band4:0.7dBi Band7:0.8dBi Band66:0.7dBi					

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3.3. Operation state

Test frequency list

Description	D
D Band 2 1.4 18607 1850.7 607 1930.	1.4 18607 1850.7 607 1930.7
D Band 2 September Septe	December 2015 Color Colo
Description	December 2015 December 201
D Band 2 10	DD Band 2 Columbridge 10
D Band 2	Test Frequency ID Bandwidth Int In
D Band 2	DD Band 2
D Band 2	Mid Range
1.4	High Range
High Range	High Range
High Range	High Range
Test Frequency ID	Test Frequency ID
Test Frequency ID	Test Frequency ID Bandwidth NoL Frequency of NoL 1906
D Band 4 Test Frequency ID Bandwidth for which a relaxation of the specified UE receiver sensitivity requirement (1) 36.101 [27] Clause 7.3) is allowed. Test Frequency ID Bandwidth Nut Frequency of Uplink [MHz] Nut Product Nut Nut Nut Nut Nut Product Nut N	NOTE 1: Bandwidth for which a relaxation of the specified UE receiver sensitivity requirement (TS 36.101 [27] Clause 7.3) is allowed.
Test Frequency ID	Test Frequency ID
Description	Test Frequency ID Bandwidth Image Imag
D Band 4	DD Band 4 1.4 19957 1710.7 1957 2110.7 3 19965 1711.5 1965 2111.5 5 19975 1712.5 1975 2112.5 10 20000 1715 2000 2115 15 20025 1717.5 2025 2117.5 20 20050 1720 2050 2120 Mid Range 1.4/3/5/10/15/20 20175 1732.5 2175 2132.5 1.4 20393 1754.3 2393 2154.3 3 20385 1753.5 2385 2153.5 13 20385 1753.5 2385 2153.5 10 20350 1750 2350 2150 15 20325 1747.5 2325 2147.5 20 20300 1745 2300 2145 Test Frequency ID
D Band 4 S	DD Band 4 Low Range
D Band 4 S	DD Band 4 Compared Figure Frequency Description Frequency Description D
DD Band 4 10	DD Band 4 10 20000 1715 2000 2115 15 20025 1717.5 2025 2117.5 20 20050 1720 2050 2120 Mid Range
Dearlog	Mid Range
Mid Range	Mid Range
Test Frequency ID	1.4 20393 1754.3 2393 2154.3 3 20385 1753.5 2385 2153.5 5 20375 1752.5 2375 2152.5 10 20350 1750 2350 2150 15 20325 1747.5 2325 2147.5 20 20300 1745 2300 2145 Test Frequency ID
High Range	High Range
High Range	High Range
Test Frequency ID	Test Frequency ID Bandwidth NuL Frequency of Uplink [MHz] Downlink [MHz] Low Range 10 20820 2750 2850 2147.5 2350 2147.5
Test Frequency ID	Test Frequency ID
D Band 7 Test Frequency ID Bandwidth MuL Frequency of Uplink (MHz) MDL Frequency of (MHz) MHz M	Test Frequency ID
Test Frequency ID	Test Frequency ID
Description	MHz
Low Range	Low Range 10 20800 2505 2800 2625 15 2002 2627.5 2011 20850 2510 2850 2630
D Band 7	15 20825 2507.5 2825 2627.5 20 19 20850 2510 2850 2630
D Band 7 20 10 20 20 20 20 20	20 ^[1] 20850 2510 2850 2630
Mid Range	
Second Part	2655 Mid Range 2010 2535 3100 2655
Test Frequency Bandwidth Nu. Frequency of ID IM ID IM ID IM ID IM ID ID	
15 21375 2562.5 3375 2682	5 21425 2567.5 3425 2687.5
19	High Range 10 21400 2565 3400 2685
NOTE 1: Bandwidth for which a relaxation of the specified UE receiver sensitivity requirement (TS 36.101 [27] Clause 7.3) is allowed.	15 21375 2502.5 3375 2002.5
Table 4.3.1.1.66-1: Test frequencies for E-UTRA channel bandwidth for operating Test Frequency Bandwidth NuL Frequency of Uplink [MHz] Downlint 1.4 131979 1710.7 66443 2110 3 131987 1711.5 66451 2111 Low Range 10 132022 1715 66486 2111 Company 10 132022 1715 1715 1715 1715 Company 10 132022 1715 1715 1715 Company 10 132022 1715 1715 1715 Company 10 132022 1715 1715 Company 10 132022 1715 1715 Company 10 132022 1715 Company 10 132022 1715 Company 10 122022 1715 Company 10 122022 1715 Company 10 122022 1715 Company 10 122022	
ID [MHz] Uplink [MHz] Downlink 1.4 131979 1710.7 66443 2110 3 131987 1711.5 66451 2111 Low Range 5 131997 1712.5 66461 2111 10 132022 1715 66486 2111 21 21 21 21 22 23 24 25 23 24 25 25 24 25 25 25 25 25 26 26 26 27 27 27 28 29 27 29 20 27 20 20 27 20 20 27 21 21 22 27 27 23 27 24 27 25 27 26 27 27 27 28 27 29 27 20 27 20 27 21 27 21 27 21 27 22 27 23 27 24 27 25 27 26 27 27 27 28 27 29 27 20 27	
3 131987 1711.5 66451 2111 5 131997 1712.5 66461 2111 10 132022 1715 66486 211	ID [MHz] Uplink [MHz] Downlink [MH
Low Range 5 131997 1712.5 66461 2112 10 132022 1715 66486 211	
Low Range 10 132022 1715 66486 211	
15 13004/ 1/1/5 66511 2/1/	5 131997 1712.5 66461 2112.5
	Low Range 5 131997 1712.5 66461 2112.5 10 132022 1715 66486 2115
	Low Range 5 131997 1712.5 66461 2112.5 10 132022 1715 66486 2115 15 132047 1717.5 66511 2117.5
Mid Dongs 4 4/2/5/40/45/20 432422 4755 66996 245	Low Range 5 131997 1712.5 66461 2112.5 10 132022 1715 66486 2115 15 132047 1717.5 66516 2117.5 20 132072 1720 66536 2120
	Low Range 5 131997 1712.5 66461 2112.5 10 132022 1715 66486 2115 15 132047 1717.5 66511 2117.5 15 132047 1717.5 66516 210 132072 1720 66536 2120 132072 1720 66736 2145 14.73[4]
	Low Range 5 131997 1712.5 66461 2112.5 10 132022 1715 66486 2115 15 132047 1717.5 66511 2117.5 15 132047 1717.5 66511 2117.5 15 132047 1717.5 66511 2117.5 10 132047 1717.5 66516 2117.5 10 132047 1720 66536 2120 132072 1720 66536 2145 10 132042 1755 66886 2155 10 132042 1755 66886 2155 10 132042 1755 16886 2155 10 132042 1755 16886 12155 10 132042 1755 10 132042 1755 16886 12155 10 132042 1755 10 132042
	Low Range
	DD Band 66 Low Range 5
	DD Band 66 Low Range 5 131997 1712.5 66461 2112.5 10 132022 1715 66486 2115 15 132047 1717.5 66511 2117.5 20 132072 1720 66536 2120 Mid Range Tx1 1.4/3/5/10/15/20 132322 1745 66786 2145 Mid Range 1.4/3/5/10/15/20 132422 1755 66886 2155 Mid Range 1.4/3/5/10/15/20 132422 1755 66886 2155 1.4 132665 1779.3 67129 2179.3 3 132657 1778.5 67121 2178.5 Paired High 5 132647 1777.5 67111 2177.5
	DD Band 66 Low Range 5 131997 1712.5 66461 2112.5
1.4 NA NA 67329 2199	DD Band 66 Low Range 5
3 NA NA 67321 2198	DD Band 66 Low Range
	DD Band 66 Low Range
	DD Band 66 Low Range
High Range ² 10 NA NA 67286 219	DD Band 66 Low Range
10 NA NA 67286 219 15 NA NA 67261 2192	DD Band 66 Low Range 5

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3.4. EUT operation mode

For RF test items

The EUT has been tested under typical operating condition. Testing was performed by configuring EUT to maximum output power status.

T	5 .	Bandwidth (MHz)				Modulation		RB#				
Test Items	Band	1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full
	2	0	0	0	0	0	0	0	0	0	0	0
Conducted Output Power	4	0	0	0	0	0	0	0	0	0	0	0
	7	-	-	0	0	0	0	0	0	0	0	0
	66	0	0	0	0	0	0	0	0	0	0	0
	2	0	0	0	0	0	0	0	0	0	-	0
Peak-to-Average	4	0	0	0	0	0	0	0	0	0	-	0
Ratio	7	-	-	0	0	0	0	0	0	0	-	0
Ratio	66	0	0	0	0	0	0	0	0	0	-	0
	2	0	0	0	0	0	0	0	0	-	-	0
99% Occupied Bandwidth & 26	4	0	0	0	0	0	0	0	0	-	-	0
Bandwidth & 26 dB Bandwidth	7	-	-	0	0	0	0	0	0	-	-	0
	66	0	0	0	0	0	0	0	0	0	-	0
	2	0	0	0	0	0	0	0	0	0	-	0
Band Edge	4	0	0	0	0	0	0	0	0	0	-	0
Dana Lage	7	-	-	0	0	0	0	0	0	0	-	0
	66	0	0	0	0	0	0	0	0	0	-	0
Conducted Spurious Emission	2	0	0	0	0	0	0	0	0	0	-	-
	4	0	0	0	0	0	0	0	0	0	-	-
	7	-	-	0	0	0	0	0	0	0	-	-
	66	0	0	0	0	0	0	0	0	0	-	-
	2	0	0	0	0	0	0	0	0	-	-	0
Frequency	4	0	0	0	0	0	0	0	0	-	-	0
Stability	7	-	-	0	0	0	0	0	0	-	-	0
,	66	0	0	0	0	0	0	0	0	-	-	0
	2	0	0	0	0	0	0	0	0	0	-	-
ERP and EIRP	4	0	0	0	0	0	0	0	0	0	-	-
LINI AND LINE	7	-	-	0	0	0	0	0	0	0	-	-
	66	0	0	0	0	0	0	0	0	0	-	-
	2	0	0	0	0	0	0	0	0	0	-	-
Radiated Spurious	4	0	0	0	0	0	0	0	0	0	-	-
Emission	7	-	-	0	0	0	0	0	0	0	-	-
	66	0	0	0	0	0	0	0	0	0	-	-
Remark	 The mark " o"means that this configuration is chosenfor testing The mark "-"means that this bandwidth is not test. The device is investigatedfrom 30MHz to10 times offundamental signal for radiated spurious emission test under different RB size/offset and modulations in exploratory test. Subsequently, only the worst case emissions are reported. 											

3.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

supplied by the manufacturer

0	- supplied by the lab		
0		Manufacturer:	/
	1	Model No.:	/
0		Manufacturer:	/
		Model No.:	/

3.6. Modifications

No modifications were implemented to meet testing criteria.

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4. TEST ENVIRONMENT

4.1. Address of the test laboratory

Laboratory: Shenzhen Huatongwei International Inspection Co., Ltd.

Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China

4.2. Test Facility

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No.: 3902.01

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 762235

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files.

IC-Registration No.:5377A

Two 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No.: 5377A.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory can also perform testing for the Australian C-Tick mark as a result of our A2LA accreditation.

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4.3. Equipments Used during the Test

Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Signal and spectrum Analyzer	R&S	HTWE0242	FSV40	100048	2020/10/19	2021/10/18
•	Signal & Spectrum Analyzer	R&S	HTWE0262	FSW26	103440	2020/10/19	2021/10/18
•	Spectrum Analyzer	Agilent	HTWE0286	N9020A	MY50510187	2020/10/19	2021/10/18
•	Radio communication tester	R&S	HTWE0287	CMW500	137688-Lv	2020/10/19	2021/10/18
•	Test software	Tonscend	N/A	JS1120	N/A	N/A	N/A

•	Radiated Spu	rious Emission					
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Semi-Anechoic Chamber	Albatross projects	HTWE0122	SAC-3m-01	N/A	2018/09/27	2021/09/26
•	Spectrum Analyzer	R&S	HTWE0098	FSP40	100597	2020/10/20	2021/10/19
•	Loop Antenna	R&S	HTWE0170	HFH2-Z2	100020	2018/04/02	2021/04/01
•	Broadband Horn Antenna	SCHWARZBECK	HTWE0103	BBHA9170	BBHA9170472	2018/10/12	2021/10/11
•	Ultra-Broadband Antenna	SCHWARZBECK	HTWE0123	VULB9163	538	2018/04/04	2021/04/03
•	Horn Antenna	SCHWARZBECK	HTWE0126	9120D	1011	2020/04/01	2023/03/31
•	Pre-amplifier	CD	HTWE0071	PAP-0102	12004	2020/11/12	2021/11/11
•	Broadband Preamplifier	SCHWARZBECK	HTWE0201	BBV 9718	9718-248	2020/05/10	2021/05/09
•	RF Connection Cable	HUBER+SUHNER	HTWE0120- 01	6m 18GHz S Serisa	N/A	2020/05/10	2021/05/09
•	RF Connection Cable	HUBER+SUHNER	HTWE0120- 02	6m 3GHz RG Serisa	N/A	2020/05/10	2021/05/09
•	RF Connection Cable	HUBER+SUHNER	HTWE0120- 03	6m 3GHz RG Serisa	N/A	2020/05/10	2021/05/09
•	RF Connection Cable	HUBER+SUHNER	HTWE0120- 04	6m 3GHz RG Serisa	N/A	2020/05/10	2021/05/09
•	RF Connection Cable	HUBER+SUHNER	HTWE0121- 01	6m 18GHz S Serisa	N/A	2020/05/10	2021/05/09
•	EMI Test Software	Audix	N/A	E3	N/A	N/A	N/A

•	Auxiliary Equipment						
Used	Test Equipment	Manufacturer	Equipment No.	Model No.	Serial No.	Last Cal. Date (YY-MM-DD)	Next Cal. Date (YY-MM-DD)
•	Climate chamber	ESPEC	HTWE0254	GPL-2	N/A	2020/10/21	2021/10/20
•	DC Power Supply	Gwinstek	HTWE0274	SPS-2415	GER835793	N/A	N/A

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4.4. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

	VN=Nominal Voltage	DC 3.70V		
Voltage	VL=Lower Voltage	DC 3.60V		
	VH=Higher Voltage	DC 4.20V		
Tomporoturo	TN=Normal Temperature	25 °C		
Temperature	Extreme Temperature	From −30° to + 50° centigrade		
Humidity	30~60 %			
Air Pressure	950-1050 hPa			

4.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01"Electromagnetic compatibilityand Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 1"and TR-100028-02 "Electromagnetic compatibilityand Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics;Part 2 " and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen Huatongweilaboratory is reported:

Test Items	Measurement Uncertainty	Notes
Transmitter power conducted	0.51 dB	(1)
Transmitter power Radiated	2.66dB for <1GHz 3.44dB for >1GHz	(1)
Conducted spurious emissions 9kHz~40GHz	0.51 dB	(1)
Radiated spurious emissions	2.66dB for <1GHz	(1)
Tradiated oparious simpolorie	3.44dB for >1GHz	(1)
Occupied Pandwidth	15Hz for <1GHz	(1)
Occupied Bandwidth	70Hz for >1GHz	(1)
Fraguency orrer	15Hz for <1GHz	(1)
Frequency error	70Hz for >1GHz	(1)

⁽¹⁾ This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=1.96.

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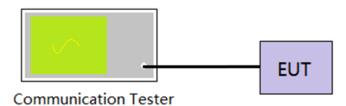
5. TEST CONDITIONS AND RESULTS

5.1. Conducted Output Power

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT output port was connected to communication tester.
- 2. Set EUT at maximum power through communication tester.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure the maximum burst average power.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix A on the section 8 appendix report

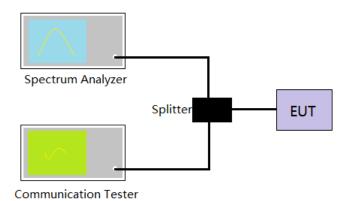
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5.2. Peak-to-Average Ratio

LIMIT

13dB

TEST CONFIGURATION



TEST PROCEDURE

- The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Center Frequency = Carrier frequency, RBW > Emission bandwidth of signal
- 4. The signal analyzer was set to collect one million samples to generate the CCDF curve
- 5. The measurement interval was set depending on the type of signal analyzed.
 - i. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms.
 - ii. For bursttransmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that issynced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in whichthetransmitter is operating at maximum power
- 6. Record the maximum PAPR level associated with a probability of 0.1%.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix B on the section 8 appendix report

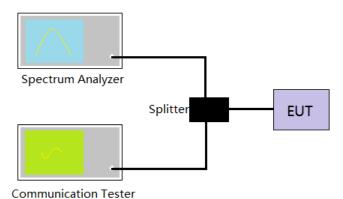
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5.3. 99% Occupied Bandwidth & 26 dB Bandwidth

<u>LIMIT</u>

N/A

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Center Frequency= Carrier frequency, RBW=1% to 5% of the anticipated OBW, VBW= 3 * RBW, Detector=Peak,

Trace maximum hold.

4. Record the value of 99% Occupied bandwidth and 26dB bandwidth.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix C on the section 8 appendix report

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5.4. Band Edge

LIMIT

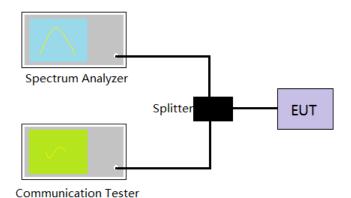
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than $40 + 10 \log (P) dB$ on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log (P) dB$ on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log (P) dB$ on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section.

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. The band edges of low and high channels were measured.
- Spectrum analyzer setting as follow:
 RBW= no less than 1% of the OBW, VBW =3 * RBW, Sweep time= Auto
- 5. Record the test plot.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix D on the section 8 appendix report

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5.5. Conducted Spurious Emissions

LIMIT

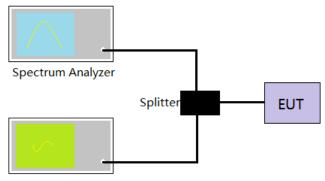
Part 24.238 and Part 22.917 and Part 27.53 specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

The specification that emissions shall be attenuated below the transmitter power (P) by at least 43 + 10 log (P) dB, translates in the relevant power range (1 to 0.001 W) to -13 dBm. At 1 W the specified minimum attenuation becomes 43 dB and relative to a 30 dBm (1 W) carrier becomes a limit of -13 dBm. At 0.001 W (0 dBm) the minimum attenuation is 13 dB, which again yields a limit of -13 dBm. In this way a translation of the specification from relative to absolute terms is carried out.

LTE Band 7

Part 27.53 m(4) For mobile digital stations, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Limit <-25 dBm

TEST CONFIGURATION



Communication Tester

TEST PROCEDURE

- 1. The EUT was connected to the spectrum analyzer and communication tester via a power splitter
- 2. Set EUT in maximum power output.
- 3. Spectrum analyzer setting as follow:

Below 1GHz, RBW=100KHz, VBW = 300KHz, Detector=Peak, Sweep time= Auto Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peak, Sweep time= Auto Scan frequency range up to 10th harmonic.

4. Record the test plot.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix E on the section 8 appendix report

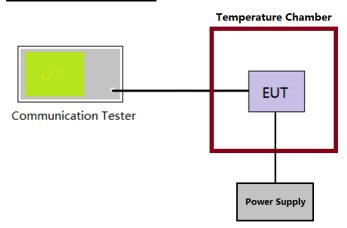
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5.6. Frequency stability VS Temperature measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber.
- 4. Turn EUT off and set the chamber temperature to –30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.
- 5. Repeat step 4 measure with 10°C increased per stage until the highest temperature of +50°C reached.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix F on the section 8 appendix report

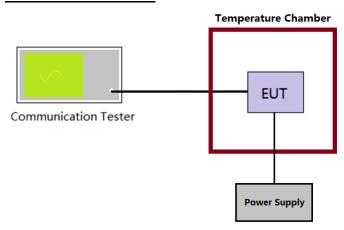
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5.7. Frequency stability VS Voltage measurement

LIMIT

2.5ppm

TEST CONFIGURATION



TEST PROCEDURE

- 1. The equipment under test was connected to an external DC power supply and input rated voltage.
- 2. The EUT output port was connected to communication tester.
- 3. The EUT was placed inside the temperature chamber at 25°C
- The power supply voltage to the EUT was varied ±15% of the nominal value measured at the input to the EUT
- 5. Record the maximum frequency change.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Refer to appendix F on the section 8 appendix report

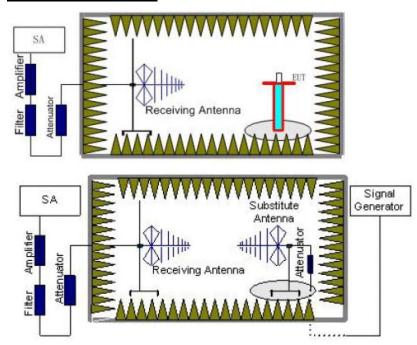
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5.8. EIRP

LIMIT

LTE Band 2/7: 2W(33dBm) EIRP LTE Band 4/66: 1W(30dBm) EIRP

TEST CONFIGURATION



TEST PROCEDURE

- 1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- 4. Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

- Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency

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6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.

- Set-up the substitution measurement with the reference point of the substitution antenna located as near
 as possible to where the center of the EUT radiating element was located during the initial EUT
 measurement.
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) - 2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

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LTE Band 2-1.4MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Result		
iviodulation	Channel	Vertical	Horizontal	Limit (dBm)			
	Low	20.34	18.15	700.00			
QPSK	Mid	20.64	18.04		PASS		
	High	20.43	18.08				
	Low	20.28	18.12	≤33.00			
16QAM	Mid	20.60	18.10		PASS		
	High	20.38	18.03				

LTE Band 2-3MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dBm)	Result		
Modulation	Chamilei	Vertical	Horizontal	Lillii (dbill)	Nesuit		
	Low	20.30	18.13	222.00			
QPSK	Mid	20.66	18.00		PASS		
	High	20.45	18.09				
	Low	20.23	18.06	≤33.00			
16QAM	Mid	20.51	18.01		PASS		
	High	20.34	18.04				

LTE Band 2-5MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Result		
iviodulation	Channel	Vertical	Horizontal	Limit (dBm)			
	Low	20.30	18.11	700.00			
QPSK	Mid	20.57	18.03		PASS		
	High	20.40	18.13				
	Low	20.30	18.19	≤33.00			
16QAM	Mid	20.54	17.98		PASS		
	High	20.31	18.03				

	LTE Band 2-10MHz							
Madulation	Channal	EIRP	(dBm)	Limit (dDm)	Dogult			
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result			
	Low	20.36	18.08	400.00				
QPSK	Mid	20.64	18.05		PASS			
	High	20.37	18.07					
	Low	20.41	18.22	≤33.00 				
16QAM	Mid	20.66	18.11		PASS			
	High	20.37	18.07					

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LTE Band 2-15MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dDm)	- I		
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result		
	Low	20.31	18.09	400.00			
QPSK	Mid	20.61	18.05		PASS		
	High	20.45	18.05				
	Low	20.24	18.12	≤33.00			
16QAM	Mid	20.54	17.99		PASS		
	High	20.36	17.99				

LTE Band 2-20MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dBm)	Result		
Modulation	Chamer	Vertical	Horizontal	Limit (dbin)			
	Low	20.29	18.09	222.00			
QPSK	Mid	20.56	17.98		PASS		
	High	20.37	18.13				
	Low	20.20	18.12	≤33.00			
16QAM	Mid	20.46	17.96		PASS		
	High	20.36	18.00				

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LTE Band 4-1.4MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dDm)	Dooult		
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result		
	Low	21.03	17.96	400.00			
QPSK	Mid	21.33	18.55		PASS		
	High	20.47	18.03				
	Low	20.93	17.91	≤30.00			
16QAM	Mid	21.24	18.63		PASS		
	High	20.36	17.92				

LTE Band 4-3MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Dogult		
Modulation	Chamei	Vertical	Horizontal	Limit (dBm)	Result		
	Low	20.96	17.92				
QPSK	Mid	21.36	18.49		PASS		
	High	20.49	18.05				
	Low	20.84	17.81	≤30.00			
16QAM	Mid	21.13	18.51		PASS		
	High	20.31	17.96				

LTE Band 4-5MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dDm)	Danill		
Modulation	Chamei	Vertical	Horizontal	Limit (dBm)	Result		
	Low	20.98	17.90	400.00			
QPSK	Mid	21.23	18.55		PASS		
	High	20.38	18.09				
	Low	21.00	18.07	≤30.00			
16QAM	Mid	21.15	18.44		PASS		
	High	20.24	17.92				

	LTE Band 4-10MHz							
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Result			
iviodulation	Channel	Vertical	Horizontal	Limit (dBm)				
	Low	21.05	17.83	400.00				
QPSK	Mid	21.34	18.58		PASS			
	High	20.38	18.04					
	Low	21.12	18.07	≤30.00				
16QAM	Mid	21.33	18.63		PASS			
	High	20.36	18.02					

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	LTE Band 4-15MHz							
Modulation	Channel	EIRP	EIRP (dBm)		- I			
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result			
	Low	20.97	17.85					
QPSK	Mid	21.33	18.61	400.00	PASS			
	High	20.50	17.99					
	Low	20.85	17.90	≤30.00				
16QAM	Mid	21.22	18.51		PASS			
	High	20.32	17.86					

	LTE Band 4-20MHz								
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Danile				
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result				
	Low	20.93	17.84						
QPSK	Mid	21.20	18.46		PASS				
	High	20.38	18.16						
	Low	20.79	17.94	≤30.00					
16QAM	Mid	21.05	18.44		PASS				
	High	20.34	17.90						

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LTE Band 7-5MHz								
Modulation	<u> </u>	EIRP (dBm)		Limit (dDm)	Dogult			
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result			
	Low	20.07	17.94					
QPSK	Mid	20.39	18.65	100.00	PASS			
	High	19.76	17.79					
	Low	20.01	17.91	≤33.00				
16QAM	Mid	20.36	18.70		PASS			
	High	19.72	17.74					

LTE Band 7-10MHz								
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Result			
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result			
	Low	20.05	17.93					
QPSK	Mid	20.38	18.60		PASS			
	High	19.80	17.82	<22.00				
	Low	19.98	17.87	≤33.00				
16QAM	Mid	20.29	18.63		PASS			
	High	19.71	17.79					

LTE Band 7-15MHz									
Modulation	Channel	EIRP	(dBm)	Limit (dPm)	Decult				
Modulation	Chame	Vertical Horizontal	Limit (dBm)	Result					
	Low	20.04	17.91	≤33.00					
QPSK	Mid	20.30	18.61		PASS				
	High	19.74	17.85						
	Low	20.06	18.01						
16QAM	Mid	20.27	18.57						
	High	19.65	17.74						

	LTE Band 7-20MHz								
Modulation	Channel	EIRP (dBm)		Limit (dPm)	Result				
iviodulation	Channel	Vertical	Horizontal	Limit (dBm)	Result				
	Low	20.08	17.88						
QPSK	Mid	20.39	18.66		PASS				
	High	19.74	17.83	<22 00					
	Low	20.10	17.99	≤33.00					
16QAM	Mid	20.37	18.67		PASS				
	High	19.74	17.82						

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LTE Band 66-1.4MHz									
Modulation	Channel	EIRP	(dBm)	Limit (dBm)	Result				
iviodulation	Channel	Vertical	Horizontal	Limit (dbm)	Result				
	Low	20.50	17.95						
QPSK	Mid	21.15	18.30		PASS				
	High	20.28	17.83	<22.00					
	Low	20.46	17.93	≤33.00					
16QAM	Mid	21.12	18.34		PASS				
	High	20.24	17.78						

LTE Band 66-3MHz									
Modulation	Channel	EIRP	(dBm)	Limit (dBm)	Result				
IVIOGUIATIOTI	Charmer	Vertical	Horizontal	Limit (ubin)	Kesuit				
	Low	20.49	17.95						
QPSK	Mid	21.17	18.28	- ≤33.00	PASS				
	High	20.30	17.85						
	Low	20.44	17.90		PASS				
16QAM	Mid	21.09	18.31						
	High	20.22	17.80						

LTE Band 66-5MHz								
Modulation	Channel	EIRP	EIRP (dBm)		Daguit			
iviodulation	Channel	Vertical	Horizontal	Limit (dBm)	Result			
	Low	20.48	17.93					
QPSK	Mid	21.11	18.30	≤33.00	PASS			
	High	20.28	17.90					
	Low	20.50	18.02					
16QAM	Mid	21.09	18.26		PASS			
	High	20.19	17.80					

	LTE Band 66-10MHz									
Modulation	Channel	EIRP	(dBm)	Limit (dBm)	Decult					
iviodulation	Channel	Vertical	Horizontal	Limit (dbin)	Result					
	Low	20.50	17.90	100.00						
QPSK	Mid	21.14	18.30		PASS					
	High	20.24	17.84							
	Low	20.53	17.99	≤33.00	PASS					
16QAM	Mid	21.14	18.33							
	High	20.24	17.83							

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	LTE Band 66-15MHz								
Modulation	Channal	EIRP	(dBm)	Limit (dDm)	Dogult				
Modulation	Channel	Vertical	Horizontal	Limit (dBm)	Result				
	Low	20.49	17.92						
QPSK	Mid	21.12	18.30	≤33.00	PASS				
	High	20.31	17.83						
	Low	20.43	17.93						
16QAM	Mid	21.08	18.27		PASS				
	High	20.23	17.76						

	LTE Band 66-20MHz									
Modulation	Channel	EIRP (dBm)		Limit (dBm)	Result					
Wiodulation	Chamilei	Vertical	Horizontal	Limit (dbin)	Nesuit					
	Low	20.44	17.89							
QPSK	Mid	21.09	18.25	- ≤33.00	PASS					
	High	20.25	17.90							
	Low	20.39	17.91							
16QAM	Mid	21.03	18.25		PASS					
	High	20.22	17.77							

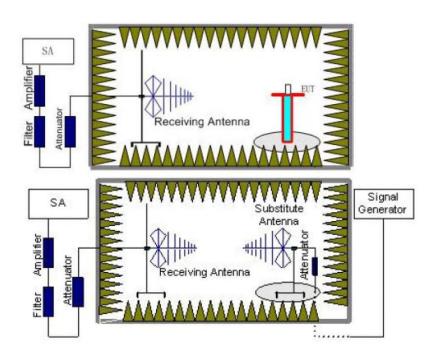
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5.9. Radiated Spurious Emission

LIMIT

LTE Band 2/4/66: -13dBm; LTE Band 7: -25dBm

TEST CONFIGURATION



TEST PROCEDURE

- 1. Place the EUT in the center of the turntable.
 - a) For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table at a nominal height of 80 cm above the reference ground plane
 - b) For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table at a nominal height of 1.5 m above the ground plane.
- 2. Unless the EUT uses an integral antenna, the EUT shall be terminated with a non-radiating transmitter load. In cases where the EUT uses an adjustable antenna, the antenna shall be adjusted through typical positions and lengths to maximize emissions levels.
- 3. The EUT shall be tested while operating on the frequency per manufacturer specification. Set the transmitter to operate in continuous transmit mode.
- Receiver or Spectrum set as follow:

Below 1GHz, RBW=100kHz, VBW=300kHz, Detector=Peak, Sweep time=Auto

Above 1GHz, RBW=1MHz, VBW=3MHz, Detector=Peck, Sweep time=Auto

- 5. Each emission under consideration shall be evaluated:
 - a) Raise and lower the measurement antenna from 1 m to 4 m, as necessary to enable detection of the maximum emission amplitude relative to measurement antenna height.
 - b) Rotate the EUT through 360° to determine the maximum emission level relative to the axial position.
 - c) Return the turntable to the azimuth where the highest emission amplitude level was observed.
 - d) Vary the measurement antenna height again through 1 m to 4 m again to find the height associated with the maximum emission amplitude.
 - e) Record the measured emission amplitude level and frequency
- 6. Repeat step 5 for each emission frequency with the measurement antenna oriented in both the horizontal

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and vertical polarizations to determine the orientation that gives the maximum emissions amplitude.

- Set-up the substitution measurement with the reference point of the substitution antenna located as near
 as possible to where the center of the EUT radiating element was located during the initial EUT
 measurement.
- 8. Maintain the previous measurement instrument settings and test set-up, with the exception that the EUT is removed and replaced by the substitution antenna.
- 9. Connect a signal generator to the substitution antenna; locate the signal generator so as to minimize any potential influences on the measurement results. Set the signal generator to the frequency where emissions are detected, and set an output power level such that the radiated signal can be detected by the measurement instrument, with sufficient dynamic range relative to the noise floor.
- 10. For each emission that was detected and measured in the initial test
 - a) Vary the measurement antenna height between 1 m to 4 m to maximize the received (measured) signal amplitude.
 - b) Adjust the signal generator output power level until the amplitude detected by the measurement instrument equals the amplitude level of the emission previously measured directly in step 5 and step 6.
 - c) Record the output power level of the signal generator when equivalence is achieved in step b).
- 11. Repeat step 8 through step 10 with the measurement antenna oriented in the opposite polarization.
- 12. Calculate the emission power in dBm referenced to a half-wave dipole using the following equation:

Pe = Ps(dBm) - cable loss (dB) + antenna gain (dBd)

where

Pe = equivalent emission power in dBm

Ps = source (signal generator) power in dBm

NOTE—dBd refers to the measured antenna gain in decibels relative to a half-wave dipole.

13. Correct the antenna gain of the substitution antenna if necessary to reference the emission power to a half-wave dipole. When using measurement antennas with the gain specified in dBi, the equivalent dipole-referenced gain can be determined from:

gain (dBd) = gain (dBi) -2.15 dB.

If necessary, the antenna gain can be calculated from calibrated antenna factor information

14. Provide the complete measurement results as a part of the test report.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

Note: only show the worse case for QPSK modulation.

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LTE Band 2-1.4MHz									
Channal	Frequency	Spurious	Emission	Lineit (dDne)	Desuit				
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result				
	3701.4	Vertical	-35.05						
	5552.1	V	-40.13	≤-13.00	Pass				
Low	7402.8	V	-42.57						
LOW	3701.4	Horizontal	-36.35						
	5552.1	Н	-41.68	≤-13.00	Pass				
	7402.8	Н	-43.57						
	3760	Vertical	-34.78	≤-13.00					
	5640	V	-39.89		Pass				
Mid	7520	V	-42.32						
IVIIG	3760	Horizontal	-36.13						
	5640	Н	-41.34	≤-13.00	Pass				
	7520	Н	-43.39						
	3818.6	Vertical	-34.53						
	5727.9	V	-39.58	≤-13.00	Pass				
High	7637.2	V	-41.91						
riigii	3818.6	Horizontal	-35.72						
	5727.9	Н	-41.11	≤-13.00	Pass				
	7637.2	Н	-43.25						

LTE Band 2-3MHz							
Channal	Frequency Spurious Emission		Emission	Lineit (dDne)	Dooult		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	3703	Vertical	-34.38				
	5554.5	V	-39.39	≤-13.00	Pass		
Low	7406	V	-41.82				
LOW	3703	Horizontal	-35.65				
	5554.5	Н	-40.96	≤-13.00	Pass		
	7406	Н	-43.07				
	3760	Vertical	-34.21		Pass		
	5640	V	-39.24	≤-13.00			
Mid	7520	V	-41.66				
IVIIU	3760	Horizontal	-35.51		Pass		
	5640	Н	-40.75	≤-13.00			
	7520	Н	-42.96				
	3817	Vertical	-34.05				
	5725.5	V	-39.05	≤-13.00	Pass		
High	7634	V	-41.40				
riigii	3817	Horizontal	-35.25				
	5725.5	Н	-40.60	≤-13.00	Pass		
	7634	Н	-42.87				

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	LTE Band 2-5MHz							
Ohamad	Frequency	Spurious	Emission	Limit (dDm)	.			
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
	3705	Vertical	-33.90					
	5557.5	V	-38.86	≤-13.00	Pass			
Low	7410	V	-41.31					
LOW	3705	Horizontal	-35.18					
	5557.5	Н	-40.45	≤-13.00	Pass			
	7410	Н	-42.69					
	3760	Vertical	-33.73		Pass			
	5640	V	-38.71	≤-13.00				
Mid	7520	V	-41.15					
IVIIG	3760	Horizontal	-35.04					
	5640	Н	-40.24	≤-13.00	Pass			
	7520	Н	-42.58					
	3815	Vertical	-33.57					
	5722.5	V	-38.52	≤-13.00	Pass			
∐iab	7630	V	-40.89					
High	3815	Horizontal	-34.78		_			
	5722.5	Н	-40.09	≤-13.00	Pass			
	7630	Н	-42.49					

LTE Band 2-10MHz							
Channal	Frequency	Spurious Emission		Lineit (dDne)	Desuit		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	3710	Vertical	-33.48				
	5565	V	-38.40	≤-13.00	Pass		
Low	7420	V	-40.83				
LOW	3710	Horizontal	-34.74				
	5565	Н	-39.99	≤-13.00	Pass		
	7420	Н	-42.38				
	3760	Vertical	-33.37		Pass		
	5640	V	-38.30	≤-13.00			
Mid	7520	V	-40.73				
iviid	3760	Horizontal	-34.65				
	5640	Н	-39.86	≤-13.00	Pass		
	7520	Н	-42.31				
	3810	Vertical	-33.27				
	5715	V	-38.18	≤-13.00	Pass		
High	7620	V	-40.57				
riigii	3810	Horizontal	-34.49				
	5715	Н	-39.77	≤-13.00	Pass		
	7620	Н	-42.26				

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LTE Band 2-15MHz							
Ohamal	Frequency	Spurious	Emission	Limit (dDms)	Б		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	3715	Vertical	-33.14				
	5572.5	V	-38.01	≤-13.00	Pass		
Low	7430	V	-40.49				
Low	3715	Horizontal	-34.43				
	5572.5	Н	-39.63	≤-13.00	Pass		
	7430	Н	-42.10				
	3760	Vertical	-32.98		Pass		
	5640	V	-37.87	≤-13.00			
Mid	7520	V	-40.35				
iviid	3760	Horizontal	-34.30				
	5640	Н	-39.44	≤-13.00	Pass		
	7520	Н	-42.00				
	3805	Vertical	-32.84				
	5707.5	V	-37.69	≤-13.00	Pass		
∐iah	7610	V	-40.12				
High	3805	Horizontal	-34.07		_		
	5707.5	Н	-39.31	≤-13.00	Pass		
	7610	Н	-41.92				

		LTE Ban	d 2-20MHz		
Channel	Frequency	Spurious	Emission	Limit (dDm)	Decult
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
	3720	Vertical	-32.76		
	5580	V	-37.58	≤-13.00	Pass
Low	7440	V	-40.07		
LOW	3720	Horizontal	-34.03		
	5580	Н	-39.22	≤-13.00	Pass
	7440	Н	-41.82		
	3760	Vertical	-32.66		Pass
	5640	V	-37.49	≤-13.00	
Mid	7520	V	-39.98		
IVIIG	3760	Horizontal	-33.95		
	5640	Н	-39.10	≤-13.00	Pass
	7520	Н	-41.76		
	3800	Vertical	-32.57		
	5700	V	-37.38	≤-13.00	Pass
High	7600	V	-39.83		
High	3800	Horizontal	-33.80		
	5700	Н	-39.02	≤-13.00	Pass
	7600	Н	-41.71		

Remark:

- 1. Remark"---" means that the emission level is too low to be measured
- 2. The emission levels of below 1 GHz are very lower than the limit and not show in test report.

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LTE Band 4-1.4MHz							
Channal	Frequency	Spurious I	Emission	Lineit (dDne)	Desuit		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	3421.4	Vertical	-34.24				
	5132.1	V	-43.60	≤-13.00	Pass		
Low	6842.8	V	-45.07				
LOW	3421.4	Horizontal	-34.96				
	5132.1	Н	-42.79	≤-13.00	Pass		
	6842.8	Н	-44.91				
	3465	Vertical	-33.97		Pass		
	5197.5	V	-43.37	≤-13.00			
Mid	6930	V	-44.84				
iviid	3465	Horizontal	-34.75				
	5197.5	Н	-42.47	≤-13.00	Pass		
	6930	Н	-44.74				
	3508.6	Vertical	-33.74				
	5262.9	V	-43.08	≤-13.00	Pass		
∐iah	7017.2	V	-44.45				
High	3508.6	Horizontal	-34.37				
	5262.9	Н	-42.25	≤-13.00	Pass		
	7017.2	Н	-44.61				

LTE Band 4-3MHz						
Channal	Frequency	Spurious I	Emission	Limeit (dDms)	D !!	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3423	Vertical	-33.60			
	5134.5	V	-42.90	≤-13.00	Pass	
Low	6846	V	-44.37			
Low	3423	Horizontal	-34.30			
	5134.5	Н	-42.11	≤-13.00	Pass	
	6846	Н	-44.44			
	3465	Vertical	-33.44		Pass	
	5197.5	V	-42.76	≤-13.00		
Mid	6930	V	-44.22			
iviiu	3465	Horizontal	-34.17			
	5197.5	Н	-41.91	≤-13.00	Pass	
	6930	Н	-44.34			
	3507	Vertical	-33.29			
	5260.5	V	-42.58	≤-13.00	Pass	
Lliah	7014	V	-43.98			
High	3507	Horizontal	-33.93			
	5260.5	Н	-41.77	≤-13.00	Pass	
	7014	Н	-44.26			

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	LTE Band 4-5MHz							
Observal	Frequency	Spurious	Emission	Limit (dDm)	D II			
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
	3425	Vertical	-33.13					
	5137.5	V	-42.31	≤-13.00	Pass			
Low	6850	V	-43.89					
LOW	3425	Horizontal	-33.78					
	5137.5	Н	-41.61	≤-13.00	Pass			
	6850	Н	-44.05					
	3465	Vertical	-32.91		Pass			
	5197.5	V	-42.11	≤-13.00				
Mid	6930	V	-43.69					
iviid	3465	Horizontal	-33.60					
	5197.5	Н	-41.33	≤-13.00	Pass			
	6930	Н	-43.91					
	3505	Vertical	-32.71					
	5257.5	V	-41.86	≤-13.00	Pass			
Lligh	7010	V	-43.35					
High	3505	Horizontal	-33.27					
	5257.5	Н	-41.14	≤-13.00	Pass			
	7010	Н	-43.80					

LTE Band 4-10MHz							
Channal	Frequency	Spurious I	Emission	Limeit (dDms)	D !!		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	3430	Vertical	-32.59				
	5145	V	-41.71	≤-13.00	Pass		
Low	6860	V	-43.28				
LOW	3430	Horizontal	-33.21				
	5145	Н	-41.02	≤-13.00	Pass		
	6860	Н	-43.66				
	3465	Vertical	-32.45		Pass		
	5197.5	V	-41.59	≤-13.00			
Mid	6930	V	-43.15				
IVIIU	3465	Horizontal	-33.10				
	5197.5	Н	-40.85	≤-13.00	Pass		
	6930	Н	-43.57				
	3500	Vertical	-32.32				
	5250	V	-41.43	≤-13.00	Pass		
High	7000	V	-42.94				
riigri	3500	Horizontal	-32.89				
	5250	Н	-40.73	≤-13.00	Pass		
	7000	Н	-43.50				

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	LTE Band 4-15MHz							
Channal	Frequency	Spurious I	Emission	Limeit (dDms)	D It			
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result			
	3435	Vertical	-32.23					
	5152.5	V	-41.25	≤-13.00	Pass			
Low	6870	V	-42.88					
LOW	3435	Horizontal	-32.74					
	5152.5	Н	-40.62	≤-13.00	Pass			
	6870	Н	-43.36					
	3465	Vertical	-32.08	≤-13.00	Pass			
	5197.5	V	-41.12					
Mid	6930	V	-42.75					
iviiu	3465	Horizontal	-32.62		Pass			
	5197.5	Н	-40.44	≤-13.00				
	6930	Н	-43.27					
	3495	Vertical	-31.95					
	5242.5	V	-40.95	≤-13.00	Pass			
∐iah	6990	V	-42.53					
High	3495	Horizontal	-32.50					
	5242.5	Н	-40.19	≤-13.00	Pass			
	6990	Н	-43.20					

LTE Band 4-20MHz						
Channal	Frequency	Spurious Emission		Limeit (dDms)	Danult	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3440	Vertical	-31.87			
	5160	V	-40.85	≤-13.00	Pass	
Low	6880	V	-42.48			
Low	3440	Horizontal	-32.42			
	5160	Н	-40.11	≤-13.00	Pass	
	6880	Н	-43.11			
	3465	Vertical	-31.78		Pass	
	5197.5	V	-40.77	≤-13.00		
Mid	6930	V	-42.40			
IVIIQ	3465	Horizontal	-32.35			
	5197.5	Н	-40.00	≤-13.00	Pass	
	6930	Н	-43.05			
	3490	Vertical	-31.70			
	5235	V	-40.67	≤-13.00	Pass	
Lliah	6980	V	-42.26			
High	3490	Horizontal	-32.21			
	5235	Н	-39.92	≤-13.00	Pass	
	6980	Н	-43.00			

Remark:

- 1. Remark"---" means that the emission level is too low to be measured
- 2. The emission levels of below 1 GHz are very lower than the limit and not show in test report.

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LTE Band 7-5MHz							
Channal	Frequency	Spurious I	Emission	Limeit (dDms)	D !!		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	5005	Vertical	-33.81				
	7507.5	V	-43.40	≤-25.00	Pass		
Low	10010	V	-43.87				
LOW	5005	Horizontal	-35.72				
	7507.5	Н	-42.79	≤-25.00	Pass		
	10010	Н	-45.00				
	5070	Vertical	-33.63		Pass		
	7605	V	-43.16	≤-25.00			
Mid	10140	V	-43.55				
iviid	5070	Horizontal	-35.26				
	7605	Н	-42.56	≤-25.00	Pass		
	10140	Н	-44.78				
	5135	Vertical	-33.42				
	7702.5	V	-42.86	≤-25.00	Pass		
Lligh	10270	V	-43.30				
High	5135	Horizontal	-34.95				
	7702.5	Н	-42.50	≤-25.00	Pass		
	10270	Н	-44.55				

LTE Band 7-10MHz						
Oh a a a a l	Frequency	Spurious	Emission	L''(/ ID)	- ·	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	5010	Vertical	-33.28			
	7515	V	-42.68	≤-25.00	Pass	
Low	10020	V	-43.21			
LOW	5010	Horizontal	-34.88			
	7515	Н	-42.35	≤-25.00	Pass	
	10020	Н	-44.38			
	5070	Vertical	-33.11	≤-25.00	Pass	
	7605	V	-42.53			
Mid	10140	V	-43.06			
IVIIU	5070	Horizontal	-34.74	≤-25.00	Pass	
	7605	Н	-42.14			
	10140	Н	-44.27			
	5130	Vertical	-32.96		Pass	
	7695	V	-42.34	≤-25.00		
High	10260	V	-42.81			
	5130	Horizontal	-34.49			
	7695	Н	-42.00	≤-25.00	Pass	
	10260	Н	-44.19			

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	LTE Band 7-15MHz						
Channal	Frequency	Spurious	Emission	Livit (IDv)	D !!		
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result		
	5015	Vertical	-32.81				
	7522.5	V	-42.09	≤-25.00	Pass		
Low	10030	V	-42.73				
LOW	5015	Horizontal	-34.36				
	7522.5	Н	-41.85	≤-25.00	Pass		
	10030	Н	-44.00				
	5070	Vertical	-32.61	≤-25.00	Pass		
	7605	V	-41.91				
Mid	10140	V	-42.55				
IVIIG	5070	Horizontal	-34.20				
	7605	Н	-41.60	≤-25.00	Pass		
	10140	Н	-43.87				
	5125	Vertical	-32.43				
	7687.5	V	-41.68	≤-25.00	Pass		
High	10250	V	-42.25				
riigii	5125	Horizontal	-33.90				
	7687.5	Н	-41.43	≤-25.00	Pass		
	10250	Н	-43.77	1			

LTE Band 7-20MHz						
Channal	Frequency	Spurious I	Emission	Lineit (dDne)	Result	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)		
	5020	Vertical	-32.32			
	7530	V	-41.54	≤-25.00	Pass	
Low	10040	V	-42.18			
LOW	5020	Horizontal	-33.85			
	7530	Н	-41.32	≤-25.00	Pass	
	10040	Н	-43.64			
	5070	Vertical	-32.19	≤-25.00	Pass	
	7605	V	-41.43			
Mid	10140	V	-42.06			
IVIIU	5070	Horizontal	-33.75			
	7605	Н	-41.16	≤-25.00	Pass	
	10140	Н	-43.56			
	5120	Vertical	-32.07			
	7680	V	-41.29	≤-25.00	Pass	
∐iab	10240	V	-41.87			
High	5120	Horizontal	-33.56			
	7680	Н	-41.05	≤-25.00	Pass	
	10240	Н	-43.50			

Remark:

- 1. Remark"---" means that the emission level is too low to be measured
- 2. The emission levels of below 1 GHz are very lower than the limit and not show in test report.

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LTE Band 66-1.4MHz						
Channel	Frequency	Spurious	Emission	Lineit (dDne)	D II	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3701.4	Vertical	-34.29			
	5552.1	V	-41.66	≤-13.00	Pass	
Low	7402.8	V	-43.04			
LOW	3701.4	Horizontal	-33.96			
	5552.1	Н	-39.48	≤-13.00	Pass	
	7402.8	Н	-42.91			
	3765	Vertical	-33.66	≤-13.00	Pass	
	5647.5	V	-41.09			
Mid	7530	V	-42.44			
IVIIU	3765	Horizontal	-33.43			
	5647.5	Н	-38.59	≤-13.00	Pass	
	7530	Н	-42.41			
	3828.6	Vertical	-32.99			
	5742.9	V	-40.26	≤-13.00	Pass	
Lliah	7657.2	V	-41.46			
High	3828.6	Horizontal	-32.46			
	5742.9	Н	-38.04	≤-13.00	Pass	
	7657.2	Н	-42.08	1		

LTE Band 66-3MHz						
Channal	Frequency	Spurious I	Spurious Emission		D It	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3703	Vertical	-32.59			
	5554.5	V	-39.75	≤-13.00	Pass	
Low	7406	V	-41.22			
LOW	3703	Horizontal	-32.27			
	5554.5	Н	-37.63	≤-13.00	Pass	
	7406	Н	-41.61			
	3765	Vertical	-32.12	≤-13.00	Pass	
	5647.5	V	-39.34			
Mid	7530	V	-40.80			
IVIIU	3765	Horizontal	-31.90			
	5647.5	Н	-37.06	≤-13.00	Pass	
	7530	Н	-41.31			
	3827	Vertical	-31.70		Pass	
	5740.5	V	-38.82	≤-13.00		
High	7654	V	-40.10			
	3827	Horizontal	-31.21			
	5740.5	Н	-36.67	≤-13.00	Pass	
	7654	Н	-41.08			

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LTE Band 66-5MHz						
Ohamad	Frequency	Spurious	Emission	L'arit (ID ar)	D 11	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3705	Vertical	-31.35			
	5557.5	V	-38.24	≤-13.00	Pass	
Low	7410	V	-39.90			
Low	3705	Horizontal	-30.89			
	5557.5	Н	-36.32	≤-13.00	Pass	
	7410	Н	-40.64			
	3765	Vertical	-30.87	≤-13.00	Pass	
	5647.5	V	-37.82			
Mid	7530	V	-39.46			
iviid	3765	Horizontal	-30.51		Pass	
	5647.5	Н	-35.73	≤-13.00		
	7530	Н	-40.33			
	3825	Vertical	-30.43			
	5737.5	V	-37.28	≤-13.00	Pass	
∐iah	7650	V	-38.74			
High	3825	Horizontal	-29.80			
	5737.5	Н	-35.33	≤-13.00	Pass	
	7650	Н	-40.09			

LTE Band 66-10MHz						
Channal	Frequency	Spurious	Emission	Lineit (dDas)	Result	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)		
	3710	Vertical	-30.17			
	5565	V	-36.95	≤-13.00	Pass	
Low	7420	V	-38.58			
LOW	3710	Horizontal	-29.68			
	5565	Н	-35.07	≤-13.00	Pass	
	7420	Н	-39.78			
	3765	Vertical	-29.87	≤-13.00	Pass	
	5647.5	V	-36.69			
Mid	7530	V	-38.31			
IVIIG	3765	Horizontal	-29.44	≤-13.00	Pass	
	5647.5	Н	-34.70			
	7530	Н	-39.59			
	3820	Vertical	-29.60		Pass	
	5730	V	-36.35	≤-13.00		
High	7640	V	-37.86			
riigii	3820	Horizontal	-28.99			
	5730	Н	-34.45	≤-13.00	Pass	
	7640	Н	-39.44	1		

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LTE Band 66-15MHz						
Ohamad	Frequency	Spurious	Emission	L' - 2 (ID)	D 1	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3715	Vertical	-29.22			
	5572.5	V	-35.61	≤-13.00	Pass	
Low	7430	V	-37.61			
LOW	3715	Horizontal	-28.36			
	5572.5	Н	-33.99	≤-13.00	Pass	
	7430	Н	-38.84			
	3765	Vertical	-28.60	≤-13.00	Pass	
	5647.5	V	-35.07			
Mid	7530	V	-37.05			
iviid	3765	Horizontal	-27.87		Pass	
	5647.5	Н	-33.23	≤-13.00		
	7530	Н	-38.44			
	3815	Vertical	-28.04			
	5722.5	V	-34.38	≤-13.00	Pass	
∐iah	7630	V	-36.13			
High	3815	Horizontal	-27.35			
	5722.5	Н	-32.16	≤-13.00	Pass	
	7630	Н	-38.13	1		

LTE Band 66-20MHz						
Channal	Frequency Spui		Emission	Lineit (dDne)	Danult	
Channel	(MHz)	Polarization	Level (dBm)	Limit (dBm)	Result	
	3720	Vertical	-27.71			
	5580	V	-33.96	≤-13.00	Pass	
Low	7440	V	-35.93			
LOW	3720	Horizontal	-27.01			
	5580	Н	-31.82	≤-13.00	Pass	
	7440	Н	-37.74			
	3765	Vertical	-27.32	≤-13.00	Pass	
	5647.5	V	-33.62			
Mid	7530	V	-35.58			
IVIIU	3765	Horizontal	-26.70		Pass	
	5647.5	Н	-31.34	≤-13.00		
	7530	Н	-37.49			
	3810	Vertical	-26.97		Pass	
	5715	V	-33.18	≤-13.00		
∐iah	7620	V	-35.00		_	
High	3810	Horizontal	-26.12			
	5715	Н	-31.01	≤-13.00	Pass	
	7620	Н	-37.30	1		

Remark:

- Remark"---" means that the emission level is too low to be measured The emission levels of below 1 GHz are very lower than the limit and not show in test report.

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6. TEST SETUP PHOTOS OF THE EUT





7. EXTERNAL AND INTERNAL PHOTOS OF THE EUT

Refere to the test report No.: CHTEW20120098

8. APPENDIX REPORT